

8961726 TEXAS INSTR (OPT0)

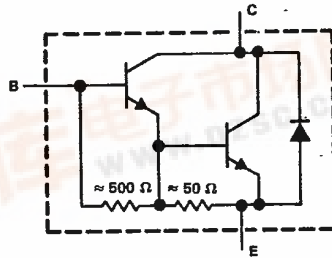
62C 37091 D

**TIPL774**  
**N-P-N DARLINGTON-CONNECTED**  
**SILICON POWER TRANSISTOR**  
 OCTOBER 1982 - REVISED OCTOBER 1984

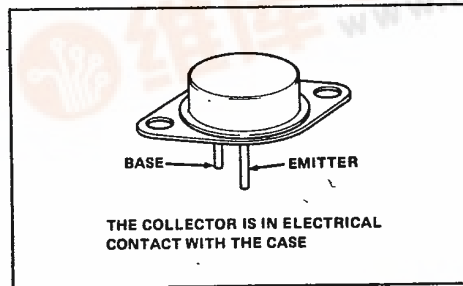
T-33-29

- 20 A Continuous Collector Current
- 150 W at 50°C Case Temperature
- Forward-Bias SOA . . . 30 V, 5 A
- Reverse-Bias SOA . . . 450 V, 15 A
- Forward Pulse Energy . . . 300 mJ
- V<sub>CEO</sub> . . . 450 V Min
- High-Voltage, High-Forward and Clamped Reverse Energy
- Designed for Ignition Systems, Motor Controls, and Solenoid Driver Applications

device schematic



TO-3 PACKAGE



absolute maximum ratings at 25°C case temperature (unless otherwise noted)

	TIPL774
Collector-base voltage	550 V
Collector-emitter voltage ( $I_B = 0$ )	450 V
Emitter-base voltage	8 V
Continuous collector current	20 A
Peak collector current (see Note 1)	30 A
Continuous base current	3 A
Continuous device dissipation at (or below) 50°C case temperature (see Note 2)	150 W
Continuous device dissipation at (or below) 25°C free-air temperature (see Note 3)	5.5 W
Operating collector junction and storage temperature range	-65°C to 200°C
Lead temperature 3,2 mm (0.125 inch) from case for 10 seconds	300°C

- NOTES: 1. This value applies for  $t_W \leq 5$  ms, duty cycle  $\leq 10\%$ .  
 2. Derate linearly to 200°C case temperature at the rate of 1 W/°C or refer to Dissipation Derating Curve, Figure 8.  
 3. Derate linearly to 200°C free-air temperature at the rate of 31.4 mW/°C or refer to Dissipation Derating Curve, Figure 9.

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**electrical characteristics at 25°C case temperature (unless otherwise noted)**

PARAMETER	TEST CONDITIONS	TIPL774			UNIT
		MIN	TYP	MAX	
V(BR)CBO	I <sub>C</sub> = 1 mA, I <sub>E</sub> = 0, See Note 4	550			V
V(BR)CEO	I <sub>C</sub> = 10 mA, I <sub>B</sub> = 0, See Note 4	450			V
V <sub>CER(sus)</sub>	I <sub>C</sub> = 7 A, See Figure 1	450			V
I <sub>CEO</sub>	V <sub>CE</sub> = 400 V, I <sub>B</sub> = 0		250		μA
	V <sub>CE</sub> = 400 V, I <sub>B</sub> = 0, T <sub>C</sub> = 150°C		1		mA
I <sub>CES</sub>	V <sub>CE</sub> = 450 V, V <sub>BE</sub> = 0		250		μA
	V <sub>CE</sub> = 450 V, V <sub>BE</sub> = 0, T <sub>C</sub> = 150°C		1		mA
I <sub>EBO</sub>	V <sub>EB</sub> = 1 V, I <sub>C</sub> = 0		5		mA
	I <sub>C</sub> = 5 A, V <sub>CE</sub> = 10 V, See Notes 4 and 5, T <sub>C</sub> = -30°C	200			
h <sub>FE</sub>	I <sub>C</sub> = 5 A, V <sub>CE</sub> = 10 V, See Notes 4 and 5	300			
	I <sub>C</sub> = 5 A, V <sub>CE</sub> = 10 V, See Notes 4 and 5, T <sub>C</sub> = 125°C	500			
	I <sub>C</sub> = 5 A, V <sub>CE</sub> = 10 V, See Notes 4 and 5				
V <sub>CE(sat)</sub>	I <sub>C</sub> = 5 A, I <sub>B</sub> = 35 mA, See Notes 4 and 5		2		V
	I <sub>C</sub> = 15 A, I <sub>B</sub> = 1.5 A, See Notes 4 and 5		3		V
V <sub>BE(sat)</sub>	I <sub>C</sub> = 5 A, I <sub>B</sub> = 35 mA, See Notes 4 and 5		2		V
V <sub>F</sub>	I <sub>F</sub> = 10 A, See Notes 4 and 5		3		V
C <sub>obo</sub>	V <sub>CE</sub> = 20 V, I <sub>E</sub> = 0, f = 0.1 MHz	120			pF

NOTES: 4. These parameters must be measured using pulse techniques, t<sub>w</sub> = 300 μs, duty cycle ≤ 2 %.  
 5. These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts located within 3.2 mm (0.125 inch) from the device body.

**thermal characteristics**

PARAMETER	MIN	TYP	MAX	UNIT
R <sub>θJC</sub>			1	
R <sub>θJA</sub>			32	°C/W
R <sub>θCHS</sub> See Note 6	0.4			
C <sub>θC</sub>	5.3			J/°C

NOTE 6: This parameter is measured using a 0.08 mm (0.003 inch) mica insulator with Dow-Corning 11 compound on both sides of the insulator with 0.138-32 mounting screws with bushings, and a mounting torque of 8 inch-pounds (0.9 newton-meters).

**resistive-load switching characteristics at 25°C case temperature**

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t <sub>on</sub>	I <sub>C</sub> = 5 A, I <sub>B1</sub> = 70 mA, V <sub>BE(off)</sub> = 0 V, R <sub>L</sub> = 100 Ω, See Figure 2			5	
t <sub>s</sub>				20	μs
t <sub>f</sub>				10	

**functional tests at 25°C free-air temperature**

TEST	CONDITIONS	MIN	TYP	MAX	LEVEL
Forward Pulse Energy $\left(\frac{I_C^2 L}{2}\right)$	I <sub>CM</sub> = 7 A, L = 12 mH, V <sub>CLAMP</sub> = 400 V, f = 75 Hz, T <sub>test</sub> = 1 s, See Figure 3		300		mJ

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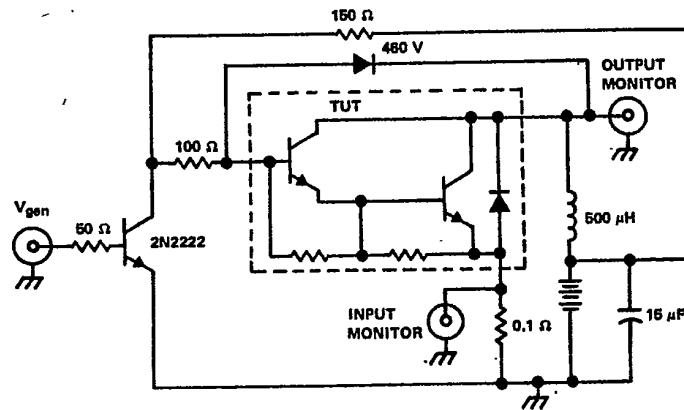
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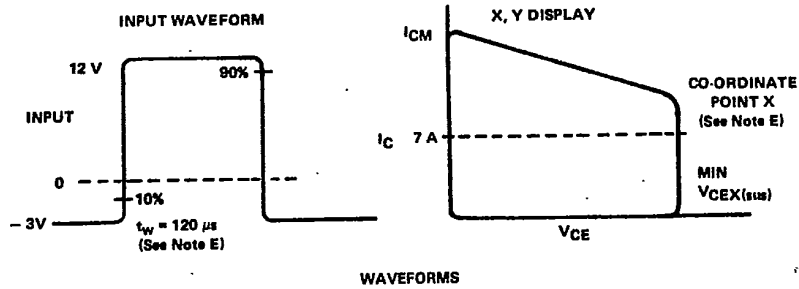
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**PARAMETER MEASUREMENT INFORMATION**

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TEST CIRCUIT



WAVEFORMS

- NOTES: A. The  $V_{gen}$  waveform is supplied by a generator with the following characteristics:  $t_r = 15 \text{ ns}$ ,  $t_f = 15 \text{ ns}$ ,  $Z_{out} = 50 \Omega$ ,  $t_w = 120 \mu\text{s}$ , duty cycle = 2%.
- B. Waveforms are monitored on an X-Y oscilloscope with the following characteristics:  $t_r = 15 \text{ ns}$ ,  $R_{in} = 10 \text{ M}\Omega$ ,  $C_{in} = 11.5 \text{ pF}$ .
- C. Resistors must be noninductive types.
- D. The d-c power supplies may require additional bypassing in order to minimize ringing.
- E. Adjust input pulse duration until collector current is 12 A at point 'X',  $I_{CM}$  must not exceed 30 A.

**FIGURE 1. COLLECTOR-EMITTER SUSTAINING VOLTAGE**

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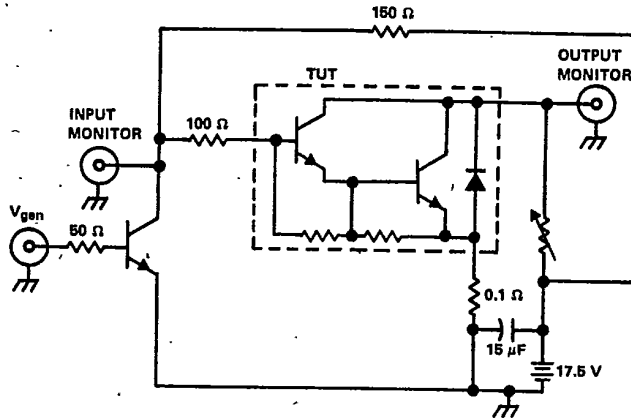
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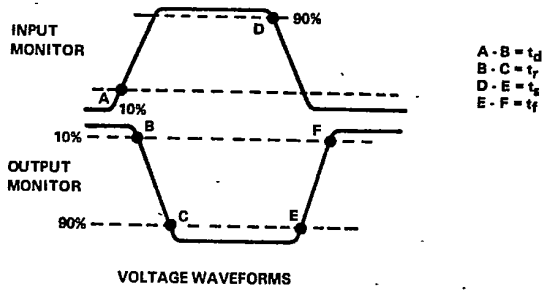
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**PARAMETER MEASUREMENT INFORMATION**



TEST CIRCUIT



VOLTAGE WAVEFORMS

- NOTES: A. The  $V_{gen}$  waveform is supplied by a generator with the following characteristics:  $t_r = 15 \text{ ns}$ ,  $t_f = 15 \text{ ns}$ ,  $Z_{out} = 50 \Omega$ ,  $t_w = 120 \mu\text{s}$ , duty cycle = 2%.
- B. Waveforms are monitored on an X-Y oscilloscope with the following characteristics:  $t_r = 15 \text{ ns}$ ,  $R_{in} = 10 \text{ M}\Omega$ ,  $C_{in} = 11.5 \text{ pF}$ .
- C. Resistors must be noninductive types.
- D. The d-c power supplies may require additional bypassing in order to minimize ringing.

FIGURE 2. RESISTIVE-LOAD SWITCHING

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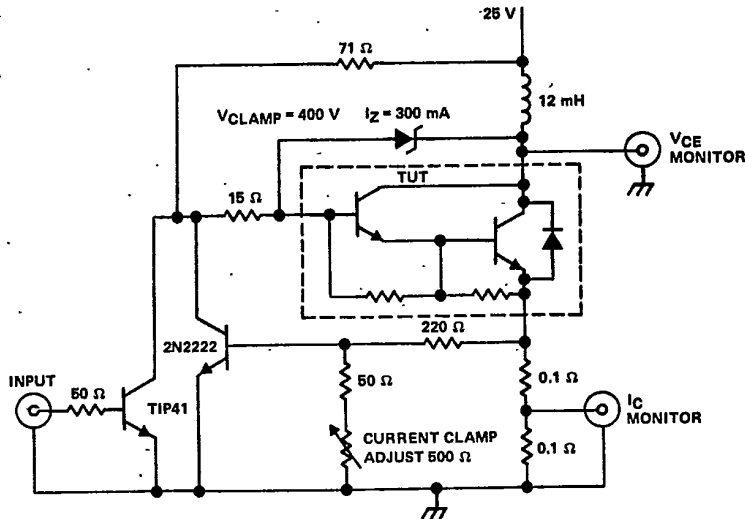
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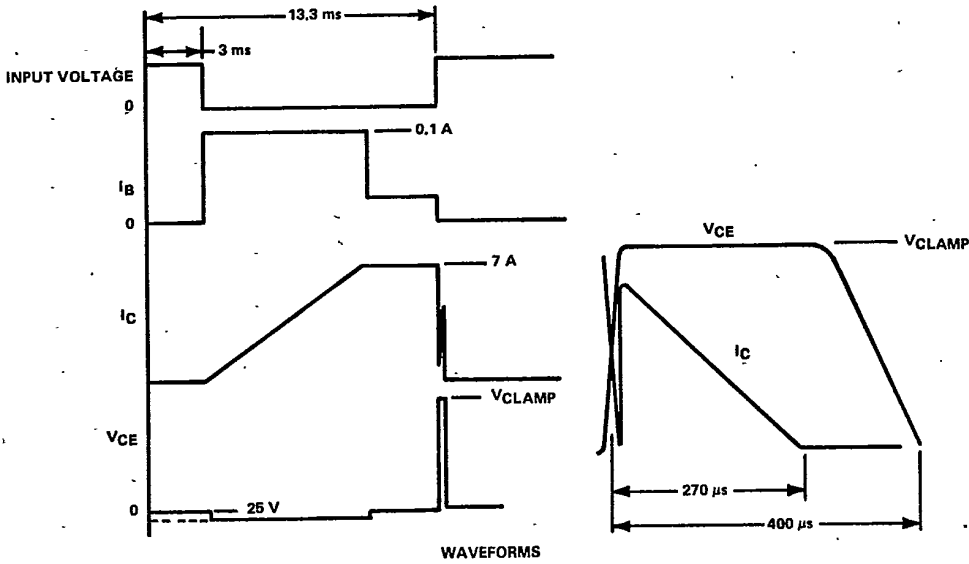
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PARAMETER MEASUREMENT INFORMATION

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TEST CIRCUIT



NOTES: A. Base and collector currents are measured using probes such as Tektronix types P6019, P6020, P6042, or the equivalent.  
B. Waveforms are monitored on an oscilloscope with the following characteristics:  $t_r \leq 20$  ns,  $R_{in} \geq 10$  M $\Omega$ ,  $C_{in} \leq 11.5$  pF.

FIGURE 3. FORWARD PULSE ENERGY

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**TYPICAL CHARACTERISTICS**

STATIC FORWARD CURRENT TRANSFER RATIO  
 vs  
 COLLECTOR CURRENT

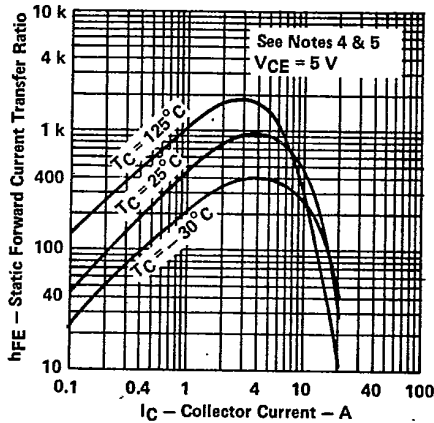


FIGURE 4

COLLECTOR-EMITTER SATURATION VOLTAGE  
 vs  
 COLLECTOR CURRENT

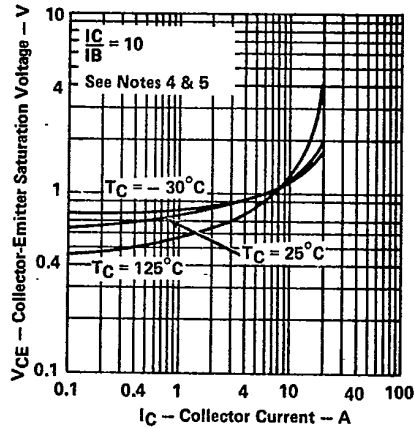


FIGURE 5

- NOTES: 4. These parameters must be measured using pulse techniques,  $t_w = 300 \mu s$ , duty cycle  $< 2\%$ .  
 5. These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts and located within 3,2 mm (0.125 inch) from the device body.

**MAXIMUM SAFE OPERATING AREA**

FORWARD-BIAS SAFE OPERATING AREA

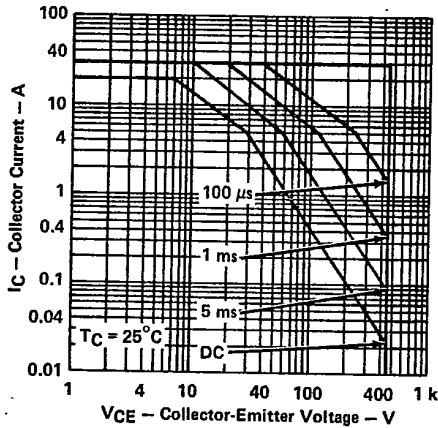


FIGURE 6

MAXIMUM COLLECTOR CURRENT  
 vs  
 CLAMPED COLLECTOR-EMITTER VOLTAGE

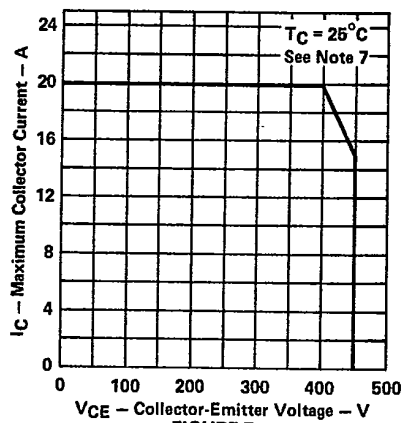


FIGURE 7

- NOTE 7: This combination of maximum voltage and current may be achieved only when switching from saturation to cut-off with a clamped inductive load as in Figure 1,  $V_{BB} = 0$ ,  $R_{BB} = 100 \Omega$ .

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THERMAL INFORMATION

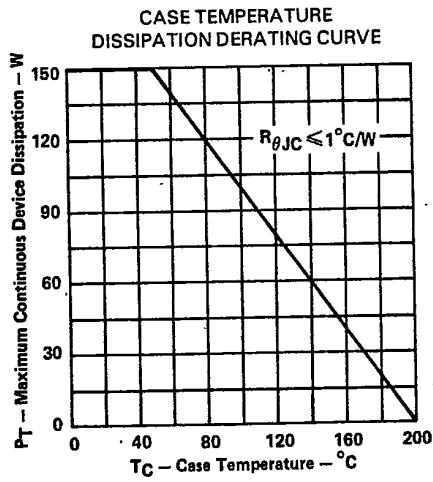


FIGURE 8

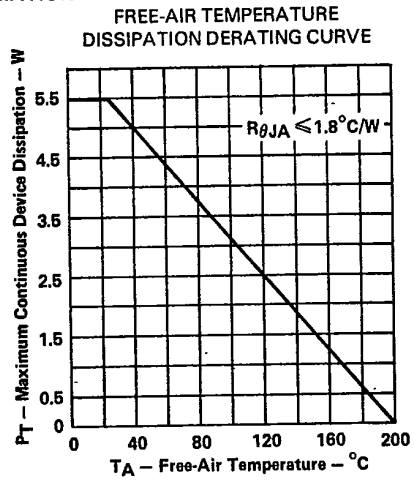


FIGURE 9

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